Do-It-Yourself Transfer of Large-Area Graphene Using an Office Laminator and Water

Shivayogimath, Abhay; Whelan, Patrick Rebsdorf; MacKenzie, David M.A.; Luo, Bichong; Huang, Deping; Luo, Da; Wang, Meihui; Gammelgaard, Lene; Shi, Haofei; Ruoff, Rodney S.

Published in:
Chemistry of Materials

Link to article, DOI:
10.1021/acs.chemmater.8b04196

Publication date:
2019

Document Version
Publisher's PDF, also known as Version of record

Link back to DTU Orbit

Citation (APA):
Do-It-Yourself Transfer of Large-Area Graphene Using an Office Laminator and Water

Abhay Shivayogimath,†‡⊥ Patrick Rebendorf Whelan,†‡§⊥ David M.A. Mackenzie,†‡⊥ Birong Luo,†⊥ Deping Huang,∥ Da Luo,∥⊥ Meihui Wang,⊥ Lene Gammelgaard,†⊥⊥ Haofei Shi,⊥⊥ Rodney S. Ruoff,⊥⊥⊥ Peter Bøggild,†⊥⊥⊥ and Timothy J. Booth†⊥⊥⊥

1DTU Nanotech, Technical University of Denmark, Ørestads Plads 345, DK-2800 Kgs. Lyngby, Denmark
2Centre for Nanostructured Graphene (CNG), Technical University of Denmark, Øresteds Plads 345C, DK-2800 Kgs. Lyngby, Denmark
3DTU Fotonik, Technical University of Denmark, Ørestads Plads 343, DK-2800 Kgs. Lyngby, Denmark
4Chongqing Institute of Green and Intelligent Technology, Chinese Academy of Sciences, 266 Fang Zheng Avenue, Chongqing 400714, P. R. China
5Center for Multidimensional Carbon Materials (CMCM), Institute for Basic Science (IBS), Ulsan 44919, Republic of Korea
6Department of Chemistry, 7School of Materials Science and Engineering, and 8School of Energy and Chemical Engineering, Ulsan National Institute of Science and Technology (UNIST), Ulsan 44919, Republic of Korea

Supporting Information

ABSTRACT: We demonstrate a simple method for transferring large areas (up to A4-size sheets) of CVD graphene from copper foils onto a target substrate using a commercially available polyvinyl alcohol polymer foil as a carrier substrate and commercial hot-roll office laminator. Through the use of terahertz time-domain spectroscopy and Raman spectroscopy, large-area quantitative optical contrast mapping, and the fabrication and electrical characterization of ~50 individual centimeter-scale van der Pauw field effect devices, we show a nondestructive technique to transfer large-area graphene with low residual doping that is scalable, economical, reproducible, and easy to use and that results in less doping and transfer-induced damage than etching or electrochemical delamination transfers. We show that the copper substrate can be used multiple times with minimal loss of material and no observable reduction in graphene quality. We have additionally demonstrated the transfer of multilayer hexagonal boron nitride from copper and iron foils. Finally, we note that this approach allows graphene to be supplied on stand-alone polymer supports by CVD graphene manufacturers to end users, with the only equipment and consumables required to transfer graphene onto target substrates being a commercial office laminator and water.

INTRODUCTION

Chemical vapor deposition (CVD) of graphene on commercial copper foils provides a scalable route toward producing continuous sheets of high-quality monolayer graphene that is being rapidly scaled toward industrial production. For most applications, graphene needs to be transferred from the growth substrate to a target substrate. This is typically done by applying a supporting polymer layer and then either chemically etching away the copper to release the graphene film or electrochemically delaminating the graphene film from the copper substrate. Chemical etching provides a reliable method of transfer, but is relatively costly because the catalyst accounts for a significant portion of the graphene production costs and can result in undesirable residual contamination because of the wet etching process. Electrochemical delamination is a popular alternative which allows for reuse of the catalyst; however, this method has inherent throughput limitations because the transfer speed is limited by the area of the electrodes, which determines the areal rate at which the graphene is delaminated. The delamination speed must also be low to prevent excessive bubbling, which can damage the graphene film because of surface tension forces. Furthermore, although both methods have been shown to be scalable, a high level of skill and expertise is still needed to perform such transfers manually, which often translates into higher complexity and cost in terms of achieving a viable production scenario.
This requirement also means that the transfer process must be carried out by the graphene supplier rather than the end-user, necessitating repeated shipment of an application-specific substrate to and from the graphene supplier. Therefore, it is advantageous for graphene manufacturers to supply CVD graphene on a generic support layer that allows easy, robust, and high-coverage transfer of the graphene onto target substrates by end-users without requiring a high level of expertise.

Recent years have shown progress in the development of convenient transfer processes with reduced contamination and the possibility of reusing the catalyst. These include methods where the underlying copper is oxidized in water, allowing the graphene to be subsequently peeled from the surface using a polymer support layer. This process takes place by intercalation of water in between the graphene and copper, after which the galvanic coupling between the more noble graphene film and copper surface leads to accelerated oxidation and corrosion of said surface and subsequent decoupling of graphene from the copper. This method is particularly attractive for scale-up because it uses only water and allows for parallelization of transfer by simultaneously oxidizing batches of graphene-coated catalyst in the water. While a number of support polymers such as polycarbonate and polymethyl methacrylate (PMMA) have been used for mechanically delaminating graphene from copper foils, these typically require removal in volatile toxic solvents such as chloroform and acetone, which necessitates special handling and disposal precautions. In this regard, polyvinyl alcohol (PVA) is an attractive alternative because it is water-soluble, allowing the entire transfer process to be done using safe and environmentally friendly solvents.

Here, we present a method for transferring large-area graphene using commercially available prefabricated PVA foils used for hydrographics printing, a commercial tabletop hot-roll laminator, and water. This method provides a simple, convenient, and reproducible transfer technique that can easily be performed by end-users to transfer graphene onto a target substrate with high uniformity and coverage and lower residual doping than etching or electrochemical delamination transfers.

We further show that the method is also effective for transferring other two-dimensional (2D) materials from metallic substrates, such as hexagonal boron nitride (hBN) from copper and iron foils.

### EXPERIMENTAL METHODS

Graphene was synthesized on a 10 cm × 10 cm commercial copper foil (127 μm thick, Alfa Aesar 13380) in a cold-wall CVD reactor (Black Magic, AIXTRON). The copper foil was electropolished in a phosphoric acid solution before CVD growth as described elsewhere. Graphene was fabricated as follows: the copper foil was annealed for 30 min at 1000 °C under 20 mbar and 700 sccm argon flow, followed by 60 min of 0.1 sccm CH₄, 50 sccm H₂, and 100 sccm Ar for graphene growth. The sample was subsequently cooled down to room temperature under argon flow.

Graphene for repeated growth and transfer experiments was synthesized on a 25 μm thick electropolished commercial copper foil (Alfa Aesar, 13382). The mass of the foil was measured before and after each growth step using a microbalance and divided by the product of the area of the copper foil and the density of copper to obtain the average thickness lost during each growth and transfer step. The foil was cleaned in acetone and isopropanol (IPA) and oxidized on a hot plate at 220 °C for 5 min prior to each growth step.

Large-area, monolayer graphene for 25 cm × 30 cm transfers was grown on 25 μm thick copper foils in a low pressure tube furnace system. The copper foil was annealed at 1000 °C with 500 sccm H₂ and 700 sccm argon flow, followed by 30 min of 100 sccm CH₄, 500 sccm H₂, and 700 sccm Ar for graphene growth. The sample was subsequently cooled down to room temperature under argon flow.

The sample was then cooled to room temperature under 2.0 Torr with 100 sccm H₂ for graphene growth. The sample was subsequently cooled to room temperature under 2.0 Torr with 100 sccm H₂ by “sliding the furnace over.” A detailed description of the single-crystal graphene film grown on the home-made Cu(111) foil will be published elsewhere.

Chemical etching and bubbling transfers of graphene on Cu(111) were performed as follows. For chemical etching transfer, a 4% wt PMMA solution was spin-coated onto copper at 1500 rpm for 1 min and baked at 80 °C for 5 min. The sample was then floated on top of a 5% HCl/H₂O₂ etching solution overnight at room temperature to remove the copper. The PMMA/graphene film was then “fished out” and rinsed in deionized (DI) water, transferred onto a 90 nm SiO₂/Si substrate, baked at 80 °C for 5 min, and placed in acetone overnight to remove PMMA. For bubbling transfer, a PMMA layer was spin-coated onto the copper at 3000 rpm for 1 min. The PMMA/graphene/Cu(111) foil stack was dipped into a 1 M NaOH aqueous solution to act as the cathode in an electrolysis cell run at constant current. The PMMA/graphene layer was delaminated from the Cu(111) foil after tens of seconds as a result of the formation of H₂ bubbles at the interface between the graphene and the Cu(111) foil. After cleaning with DI water, the floating PMMA/graphene layer was “fished out” and transferred to the target substrate (90 nm SiO₂/Si). Finally, the sample was dried and PMMA removed with acetone.

PVA lamination transfer of graphene was performed according to the procedure illustrated in Figure 1. Commercial water-soluble PVA films of 30 μm thickness were purchased from Chengdu Han Shang Water Transfer Printing Co., Ltd (HS Inkjet Printable Blank PVA Water Transfer Printing Film). The films are transparent and come supported on a white sheet of paper. They were initially rinsed in IPA and dried under nitrogen flow. Copper foils with as-grown graphene

![Figure 1](image_url)

**Figure 1.** (a) Schematic illustration of the PVA lamination transfer process: (1) copper foils with as-grown graphene are oxidized in DI water at room temperature for more than 8 h (overnight); (2) the oxidized foils are subsequently laminated with a commercially available PVA film using a commercial hot-roll laminator. (3) After a 30 s bake on a hot plate at 110 °C, the PVA film is mechanically delaminated from the copper surface, taking the graphene film along with it (4). (b,c) Graphene transferred from a 10 cm × 10 cm copper foil; the dashed lines serve as a visual guide marking the edges of the graphene sheet on the PVA film. (c) PVA–graphene film [from panel (b)] compared with a 4″ SiO₂ on Si wafer.
were placed overnight in DI water at room temperature to oxidatively decouple the graphene from the catalyst surface. After drying the copper substrate, the IPA-rinsed PVA film was laminated on top of the graphene-copper foil at 110 °C and a speed of 20 cm/min using a commercial hot-roll office laminator (Akiles Pro-Lam photo 6). The laminate was then baked on a hot plate at 110 °C for 30 s to improve adhesion between the PVA and graphene. The PVA film was then mechanically delaminated from the copper surface, lifting the graphene along with it. The graphene layer is now available as a transferrable layer on a mechanically stable and rigid polymer substrate, ready to be transported and eventually deposited on an arbitrary substrate. This was done by laminating the PVA–graphene film onto a target substrate under the same lamination conditions, baking it on a hot plate at 110 °C for 1 min, peeling off the paper support while the sample is still on the hot plate and finally removing the PVA in room temperature DI water overnight.

Transferred graphene layers were characterized by Raman spectroscopy, optical microscopy, terahertz time-domain spectroscopy (THz-TDS), and four-point van der Pauw (vdP) electrical device measurements. Raman spectroscopy was conducted in a Thermo Fisher DXR microscope equipped with a 455 nm laser (5 mW, 3 × 10 s exposure time, 50X objective). Raman spectral maps for comparative studies between etching, bubbling, and PVA lamination transfers were collected over 969 spectra spread evenly across a 150 μm × 72 μm area. Optical images were acquired using a Nikon Eclipse L200N equipped with a programmable Prior Scientific XYZ stage. Optical images were stitched to form optical and graphene coverage maps of the samples. For the graphene coverage maps, each pixel in the optical image is filtered according to the expected red, green, and blue contrasts for graphene on a 90 nm SiO2/Si substrate. This makes it possible to produce a coverage map highlighting regions of single-layer graphene, bilayer graphene, SiO2 substrate, and “other” - pixels here designated as “other” when they indicate more than two layers of graphene or with contaminants from the growth and transfer processes.

THz-TDS measurements were conducted using a commercially available fiber-coupled spectrometer.20 Spatial THz-TDS maps were acquired by raster scanning the samples at normal incidence in the focal plane of the THz beam using 400 μm step size for graphene on oxidized silicon and 1 mm step size for graphene on PVA. The THz spot size is ∼350 μm at 1 THz. The frequency-dependent sheet conductivity of graphene was extracted from the ratio of THz radiation passing through graphene-covered sample regions and a substrate reference area with no graphene. The transient from the directly transmitted pulse was used for graphene on 90 nm SiO2 on high resistivity (HR) Si wafer, whereas for graphene on PVA, all internally reflected echoes were taken into account as done in ref 22. THz-TDS sheet conductivity maps show the spatially averaged sheet conductivity in the 0.3–1.1 THz range. The DC conductivity σdc and scattering time τ can be extracted from THz-TDS measurements of graphene by fitting the frequency-dependent sheet conductivity of graphene to the Drude-model (Figure S1), \( \sigma(\omega) = \sigma_\text{Drude}/(1+i\omega\tau) \), where \( \sigma_\text{Drude} \) is the frequency-dependent sheet conductivity.22 The carrier density n and mobility μ of graphene can subsequently be calculated as \( n = n^2 \sigma_\text{Drude}/(e^2 v_F^2) \) and \( \mu = \sigma_\text{Drude}/(n^2 e v_F) \) where \( v_F \) is the Fermi velocity set to 10^6 m/s.24 Devices for vDP measurements were fabricated according to the steps illustrated in Figure 2. Cr/Au electrodes are evaporated through a shadow mask onto a 4″ 90 nm SiO2 on HR-Si wafer. The graphene transferred here was from the 100 mm × 100 mm graphene on the PVA foil shown in Figure 1b. Optical microscopy and THz-TDS measurements both confirm that a continuous layer of electrically conductive graphene was transferred over the entire sample area. The THz-TDS map shows an average sheet conductivity of ∼0.5 mS and is relatively homogeneous across the area. One can observe regions with darker contrast near the center and edges of the film in Figure 3b,c, which correspond to higher conductivity areas in the THz-TDS map (Figure 3d)—these are due to adlayers that originate from the growth process itself, as confirmed by scanning electron micrographs (SEM) of the catalyst surface before transfer (Figure S2). A region in the bottom right corner is visible in both the optical and THz-TDS maps where the graphene was damaged during handling.

For field effect measurements, graphene was transferred onto a 4″ 90 nm SiO2/Si wafer with 49 prefabricated device contacts (Figure 2a,b) and laser-patterned to form defined device geometries (Figure 2d). Back-gated electrical measurements were conducted on 10 different 5 mm × 5 mm devices with varying distance to the wafer center (Figure 2c). Typical device characteristics are shown in Figure 4a. The charge neutrality point for all devices lies between −3 and +1 V, which corresponds to low residual doping levels below 8 × 10^11 cm^-2.

\[ \varepsilon_{exx}/\kappa_S + \varepsilon_{exx}/\kappa_C = 1 \] (1)

and with the gate-dependent device uniformity parameter defined as:25

\[ \beta = \frac{R_A}{R_C} \] (2)

RESULTS

Figure 3 shows optical and THz-TDS characterization of a graphene film transferred onto a 4″ 90 nm SiO2 on HR-Si wafer. The graphene transferred here was from the 100 mm × 100 mm graphene on the PVA foil shown in Figure 1b. Optical microscopy and THz-TDS measurements both confirm that a continuous layer of electrically conductive graphene was transferred over the entire sample area. The THz-TDS map shows an average sheet conductivity of ∼0.5 mS and is relatively homogeneous across the area. One can observe regions with darker contrast near the center and edges of the film in Figure 3b,c, which correspond to higher conductivity areas in the THz-TDS map (Figure 3d)—these are due to adlayers that originate from the growth process itself, as confirmed by scanning electron micrographs (SEM) of the catalyst surface before transfer (Figure S2). A region in the bottom right corner is visible in both the optical and THz-TDS maps where the graphene was damaged during handling.
The field-effect mobility was calculated via \( \mu = \left( \frac{L}{W} \right) \left( C_{oxide} V_{SD} \right)^{-1} \left( \frac{dI}{dV_G} \right) \) \(^{33}\) and found to be in the range of 350–800 cm\(^2\) V\(^{-1}\) s\(^{-1}\). We found the vdP uniformity parameter of the device to be \( \beta < 2 \) (shown in Figure 4a inset), which is typical for high-quality large-scale CVD graphene devices that have been uniformly transferred within the device areas.\(^{32}\)

When \( n \) and \( \mu \) are plotted as a function of position on the wafer, we do not observe any systematic variation between the wafer center and wafer edge, as shown in Figure 4b. All 49 devices were electrically conductive, indicating a 100% transfer yield.

PVA lamination transfer was benchmarked against standard chemical etching and bubbling transfer using Raman spectroscopy and THz-TDS measurements. Here, we used high-quality monocrystalline graphene on Cu(111) foils\(^{34,35}\) to mitigate the effects of defects from growth from those introduced during transfer. THz-TDS measurements were used as a noninvasive tool to extract charge carrier density and mobility that avoids defects and doping induced by device fabrication.\(^{30}\) Extracted values for charge carrier density and mobility from THz-TDS measurements and Raman spectral figures of merit are shown in Figure 5. Graphene from PVA lamination transfer exhibits lower charge carrier densities than either etching or bubbling transfers (Figure 5a), which corroborates the low residual doping seen from gated conductance measurements in Figure 4. This method also results in the lowest distribution in carrier density, which suggests that what little doping is introduced by transfer is more homogeneously distributed. Extracted mobility values are also \( \sim 2 \times \) higher for PVA lamination transfer as compared to etching or bubbling transfers (Figure 5b). Raman spectra of graphene from PVA lamination transfer have higher average 2D/G (Figure 5c) and lower D/G ratios (Figure 5d) and a lower 2D full-width at half maximum (FWHM) (Figure 5e) compared with the other two methods. In general, we observe bubbling transfer to result in higher doping, lower carrier mobility, and higher incidence of defects (as inferred from Figure 5d and Raman D-peak intensity in Figure S3) than the other two transfers. The results suggest that after controlling for growth- or fabrication-induced defects and doping, etching or bubbling transfer have a greater detrimental

Figure 3. (a) Photograph of a 4” 90 nm SiO\(_2\) on HR-Si wafer with graphene transferred on top. (b) Stitched optical microscopy map of wafer from (a). (c) Coverage map from (b), where light gray represents single-layer graphene, dark gray represents the bilayer regions, white represents the substrate regions, and black represents the “other” regions: regions with more than two graphene layers or with contaminants from the growth and transfer processes. (d) THz-TDS sheet conductivity map of the graphene film transferred onto a 90 nm SiO\(_2\)/Si wafer. The average sheet conductivity in (c) is \( \sim 0.5 \) mS.

Figure 4. Electrical measurements from wafer-scale transfer. (a) Typical sheet conductivity (\( \sigma_s \)) measurements of a 5 mm \( \times \) 5 mm device. Inset: Device homogeneity (\( \beta \) in eq 2) as a function of gate bias. (b) Residual doping (\( n \)) and carrier mobility (\( \mu \)) as a function of the distance from wafer center (as defined in Figure 2c).
impact on graphene properties as compared to our PVA lamination transfer.

To demonstrate the scalability of our transfer method, CVD graphene grown on a 30 cm $\times$ 25 cm electropolished copper foil was transferred onto a PVA support film, as shown in Figure 6. The graphene film is visible by eye as a continuous region of darker contrast on the PVA foil (Figure 6a). THz-TDS mapping of the average sheet conductivity of graphene on the PVA foil shows a continuous conductive layer transferred onto the PVA foil with an average sheet conductivity of $\sim$1 mS. Streaking lines observed in the THz-TDS conductivity map (Figure 6b) are areas where the graphene was not properly transferred because the PVA film was not in close contact with the copper, which we attribute to thermal and mechanical stresses in the PVA foil during the lamination process.

Figure 7 shows results from repeated growth and transfer of graphene from a single 25 $\mu$m electropolished copper foil as characterized by optical and Raman spectroscopy. Continuous sheets of graphene were transferred in all five trials, as seen in the optical micrographs in Figure 7a–e. Tears, holes, and polymer residues are occasionally observed in the optical images. Raman characterization in Figure 7f corroborates these observations by the presence of a small D-peak located at 1350 cm$^{-1}$; the frequency and magnitude of these defects, however, appear to be random across repeated trials and thus not inherent to the transfer process itself. We found that a large number of creases formed on the thin 25 $\mu$m foils when mechanically delaminating the PVA film, which persisted and adversely affected the quality of subsequent growth and transfers, leading to many of the macroscopic tears seen in transferred samples. Using a thicker foil (such as in Figure 3) virtually eliminated these creases.

The amount of copper lost following each growth and transfer cycle was recorded by measuring the mass of the foil on a microbalance before and after each growth, and is presented in Figure 7g. From these measurements, we observe
that copper loss from the transfer process is minimal (within an instrumental error of ±1.7 nm) and that most of the loss occurs via evaporation during low pressure growth. Figure 7g also shows that the copper lost during the first transfer (T1) was more significant than in subsequent transfers—the copper foil was oxidized in hot water after the first growth, forming black cuprous oxides, which subsequently delaminated along with the graphene during transfer.

The present process can also be used to transfer other 2D materials from metal surfaces. Figure 8 shows the results of transferring multilayer boron nitride sheets from copper and iron foils onto 90 nm SiO2/Si substrates. Multilayer boron nitride was grown using methods described in literature.36,37 Of particular note is the fact that the copper foils did not need to be oxidized to peel off the boron nitride film. Water oxidation led to more wrinkles in transferred hBN films (Figure 8c) than when oxidation was omitted (Figure 8b). Multilayer boron nitride films grown on iron foils had a nonuniform thickness. The films were transferred onto 90 nm SiO2/Si substrates without oxidizing the foils in water; the transferred films were discontinuous with primarily multilayer regions being transferred (Figure 8d). Water oxidation is not suitable for iron foils because of excessive rust formation, which is then transferred along with the films in subsequent steps.

**DISCUSSION**

Our results demonstrate that PVA lamination transfer is a commercially viable approach for transferring large-scale graphene from the copper catalyst onto target substrates in a convenient and reproducible manner. We show from THz-TDS and Raman spectroscopy that graphene transferred via PVA lamination has lower and more homogeneous residual doping, higher charge carrier mobility, and fewer transfer-induced defects as compared to standard chemical etching or electrochemical delamination transfers. Through fabrication and characterization of large-scale electrical devices, we show that PVA lamination transfer provides high device yields with wafer-scale transport consistency. We further demonstrate, through the use of large-area THz-TDS characterization, that electrically continuous graphene films can be easily transferred over arbitrary length scales in a roll-to-roll fashion that is limited only by the dimensions of the catalyst. Finally, we show that other 2D materials can also be transferred from various substrates by this approach, as long as the material can be sufficiently decoupled from the substrate.

While PVA lamination transfer provides a high yield of devices with minimal residual doping, we nonetheless observe a small asymmetry in the conductivity of holes and electrons and a slight n-doping in gated conductance measurements in Figure 4a, which we attribute to PVA residues.38 We also note that the carrier mobility values in these large-scale devices are lower than those reported in the literature for other transfer methods for micrometer-scale devices;5,7,9,39 the devices

---

**Figure 7.** (a−e) Optical micrographs of repeated growth and transfer of graphene onto 90 nm SiO2/Si substrates, where the sequential transfer index is indicated in the top right corner (scale bar 20 μm). (f) Corresponding Raman spectra of the samples in (a−e). (g) Plot of the average thickness of copper lost during each process step, where “G” refers to the growth step and “T” refers to the transfer step; the numbers at the top axis indicate the average thickness of copper lost during each step, where a negative sign indicates a net loss in mass and a positive value indicates a gain in mass. The mass here was measured on a microbalance before and after each growth step. The instrumental precision of the microbalance, when converted to corresponding units of thickness, is ±1.7 nm.

---

**Figure 8.** (a,b) Multilayer boron nitride (30 nm thick) transferred onto 90 nm SiO2/Si substrates from copper foils without a prior wet oxidation step. (c) Multilayer boron nitride transferred in the same manner as (a,b), but with a prior wet oxidation step. (c) Multilayer boron nitride transferred from an iron foil onto 90 nm SiO2/Si substrate without prior wet oxidation.
presented here have an area 5 orders of magnitude larger than a typical 10 μm × 10 μm sized device. As the device area increases, large-scale inhomogeneities from growth, transfer, wafer variation, inconsistent polymer residues and so forth, which are less pronounced in individual small-scale devices, can play a significant role and lead to a lower measured mobility. Furthermore, doping and damage induced during growth and/or device fabrication can often mask or exacerbate the effects of transfer, making comparisons between different transfer methods difficult without accounting for these effects.

For more accurate comparisons between transfer methods, we used high-quality monocrystalline graphene on Cu(111) foils to decouple defects introduced during growth from transfer and THz-TDS and Raman measurements as noninvasive, noncontact tools to characterize the electrical and structural quality of the graphene immediately after transfer and prior to any processing. In doing so, we were able to see clear differences in the graphene quality obtained between the three transfer methods.

Transfer of multilayer hBN showed some important differences from graphene transfer. In particular, water oxidation was not necessary for transfer and in fact led to more wrinkles in the hBN film. A possible mechanism for this wrinkling is weak binding with the growth substrate after water oxidation, combined with different rates of thermal expansion during hot lamination. The wrinkles are also large because of a lower ability of thicker hBN to conform to the target substrate during hot lamination. The wrinkles are also large because of a lower ability of thicker hBN to conform to the target substrate as compared to monolayer graphene. Direct delamination of hBN was also possible from iron foils; however, the transferred films were discontinuous. This may be a product of the nonuniform thickness of the grown film and stronger adhesion of boron nitride to iron as compared with copper, where the transfer mechanism at work resembles mechanical exfoliation of bulk h-BN rather than oxidative decoupling.

In general, we find that the quality and surface roughness of as-grown graphene on copper and contact between the PVA foil and substrate surface play an important role in the amount of defects (such as tears and holes) that is introduced during transfer. Microscopic tears appear to originate from poorly stitched graphene grain boundaries or tears and wrinkles already present in the as-grown graphene on copper. Macroscopic tears are seen in areas where the PVA foil is unable to make a close physical contact with the surface, such as rolling lines, creases, or mechanical deformations in the catalyst foil. Finally, holes are typically seen in regions with trapped air bubbles from lamination.

We envision a number of routes for increasing the throughput and quality of the present method for industrial scale-up. Although long processing times are used here to ensure complete decoupling of graphene from the catalyst surface during water oxidation and removal of PVA, hot water can oxidize copper and decouple graphene in less than an hour, and thinner PVA foils can be used to permit faster dissolution. Throughput can be increased further by performing these steps in large batches. Finally, roll-to-roll processing under tension, vacuum lamination, and thick Cu foils (>50 μm) can be employed to reduce trapped bubbles, tearing, and other possible issues when scaling up this technology.

PVA lamination transfer provides a unique solution for industrial-scale graphene transfer: prefabricated PVA foils are inexpensive and readily available in industrial quantities and provide a mechanically robust support on which graphene can be supplied, while the simplicity of this lamination technique lowers the entry barrier for graphene transfer onto arbitrary substrates. As a result, instead of having to develop the expertise and provide graphene already transferred to application-specific substrates, graphene manufacturers can now provide high-quality CVD graphene on standalone, ready-to-transfer foils that can be cut, shaped, and transferred as needed onto application-specific target substrates by the end-users using off-the-shelf office tools and water. Not only does this reduce production costs on the side of the manufacturer by allowing reuse of the copper catalyst, but it also makes CVD graphene available to a much larger base of potential users—not just the experts—and enables do-it-yourself application of graphene films onto various target substrates by end-users with minimal investment of time and money.

■ CONCLUSION

We have demonstrated how commercially available PVA films widely used for the hydrographic transfer of printed images can be employed to mechanically transfer graphene from growth substrates to target substrates using a low-cost office laminer. The PVA foils act not only as a robust backing during handling but are also a convenient means to store or transport ready-to-apply graphene to end-users, without previous experience with graphene transfer, who simply need to use their own low-cost laminer to apply the graphene on-site to any substrate of interest. By avoiding resist spinning or other complex processing, the need for catalyst etching and recovery and the use of organic solvents; and using only nontoxic and biodegradable materials, we have demonstrated a process which is greener, of lower cost, highly scalable, and more convenient for graphene growers and end-users than existing techniques and has considerable potential for further development and use in research and industry.

■ ASSOCIATED CONTENT

Supporting Information

The Supporting Information is available free of charge on the ACS Publications website at DOI: 10.1021/acs.chemmater.8b04196.

Frequency-dependent conductivity from THz-TDS measurements of transferred graphene, optical and SEM characterization of graphene from Figure 3, and characteristic Raman spectrum of graphene transferred by PVA lamination, bubbling, and etching transfers (PDF)

■ AUTHOR INFORMATION

Corresponding Author
E-mail: tibo@du.dk.

ORCID

Abhay Shivayogimath: 0000-0002-5152-0327
Patrick Rebsdorf Whelan: 0000-0002-3978-7029
David M.A. Mackenzie: 0000-0003-1114-2955
Da Luo: 0000-0002-9128-6782
Peter Bøggild: 0000-0002-4342-0449

Present Addresses

©DTU Physics, Technical University of Denmark, Ørsteds Plads 345, DK-2800 Kgs. Lyngby, Denmark
¶Department of Electronics and Nanoengineering, Aalto University, P.O. Box 13500, FI-00076 Aalto, Finland
A.S. conceived and developed the transfer process under the supervision of T.J.B. and P.B. P.R.W performed optical contrast mapping and THz-TDS characterization. D.M.A.M. performed device fabrication and electrical characterization. L.G. aided in device fabrication and characterization. B.L. provided samples of CVD h-BN grown on copper. H.D. and H.S. provided A4-size sheets of as-grown graphene on copper. H.D. and R.S.R provided graphene on Cu (111), and M.W. performed electrochemical delamination transfer. T.J.B. and P.B. supervised the project. A.S. wrote the manuscript and prepared the figures, and all authors contributed to manuscript revisions.

The authors declare no competing financial interest.

ACKNOWLEDGMENTS

A.S., B.L., P.B., and T.J.B. acknowledge the support from the EU Seventh Framework Programme (FP7/2007-2013) under grant agreement number FP7-6040007 "GLADIATOR". P.R.W., D.M.A.M., L.G., and P.B. acknowledge the support from the EU Horizon 2020 Future and Emerging Technologies programme under grant agreement numbers 696656 and 785219. D.L. and R.S.R acknowledge the support from IBS-R019-D1. A.S., T.J.B., and P.B. acknowledge the support from the Danish National Research Foundation Center of Excellence for Nanostructured Graphene (CNG), project DNRF103.

REFERENCES
